

Notice of References Cited	Application/Control No. 10/782,654	Applicant(s)/Patent Under Reexamination SAITO ET AL.	
	Examiner David L. Ometz	Art Unit 2653	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,790,541	09-2004	Saito et al.	428/692
	B	US-			
	C	US-			
	D	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	Examiner Louis Falasco	Art Unit 1773	Page 1 of 1

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	K	US-			
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